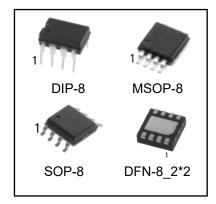


# 1MHZ CMOS Rail-to-Rail IO Opamp with RF Filter

### Features

- Single-Supply Operation from +2.1V ~ +5.5V
- Rail-to-Rail Input / Output
- Gain-Bandwidth Product: 1MHz (Typ.)
- Low Input Bias Current: 1pA (Typ.)
- Low Offset Voltage: 3.5mV (Max.)
- Quiescent Current: 40µA per Amplifier (Typ.)
- Operating Temperature: -40°C ~ +125°C
- Embedded RF Anti-EMI Filter

### Ordering Information



DEVICE	Package Type	MARKING	Packing	Packing Qty
LMV602PG	DIP-8	LMV602	TUBE	2000pcs/Box
LMV602DRG	SOP-8	LMV602	REEL	2500pcs/Reel
LMV602DGKRG	MSOP-8	LMV602,V602	REEL	3000pcs/Reel
LMV602DQRG	DFN-8_2*2	LMV602	REEL	2500pcs/Reel

### **General Description**

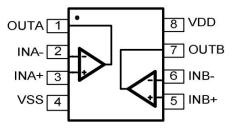
The LMV602 have a high gain-bandwidth product of 1MHz, a slew rate of  $0.6V/\mu s$ , and a quiescent current of  $40\mu A/amplifier$  at 5V. The LMV602 is designed to provide optimal performance in low voltage and low noise systems. They provide rail-to-rail output swing into heavy loads. The input common mode voltage range includes ground, and the maximum input offset voltage is 3.5mV for LMV602. They are specified over the extended industrial temperature range ( $-40^{\circ}C$  to+ $125^{\circ}C$ ). The operating range is from 2.1V to 5.5V. The LMV602 Dual is available in Green SOP-8, MSOP8, DIP-8 and DFN-8 packages.

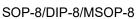
## Applications

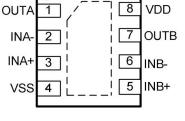
- ASIC Input or Output Amplifier
- Sensor Interface
- Medical Communication
- Smoke Detectors
- Audio Output
- Piezoelectric Transducer Amplifier
- Medical Instrumentation
- Portable Systems



## **Pin Configuration**







DFN-8 2\*2



## **Absolute Maximum Ratings**

Condition	Min	Мах				
Power Supply Voltage (V <sub>DD</sub> to Vss)	-0.5V	+7.5V				
Analog Input Voltage (IN+ or IN-)	Vss-0.5V	V <sub>DD</sub> +0.5V				
PDB Input Voltage	Vss-0.5V	+7V				
Operating Temperature Range	-40°C	+125°C				
Junction Temperature	+160°C					
Storage Temperature Range	-55°C	+150°C				
Lead Temperature (soldering, 10sec)	+24	5°C				
Package Thermal Resistance (TA=+25℃)						
SOP-8, θJA	125°	C/W				
MSOP-8, 0JA	216°C/W					
ESD Susceptibility						
НВМ	6K	ίV				
MM	300	DV				

Note: Stress greater than those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification are not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.



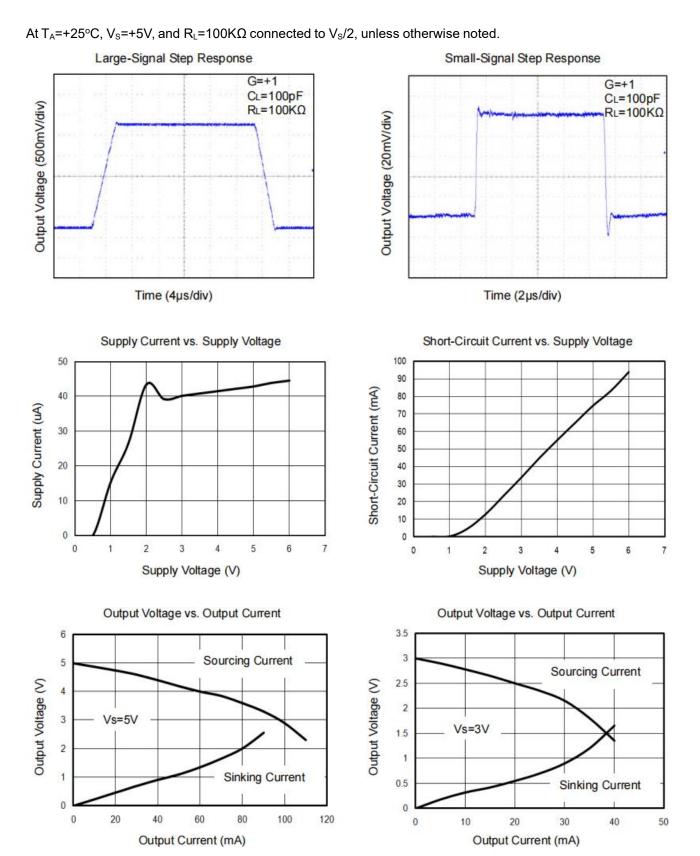
## **Electrical Characteristics**

PARAMETER	SYMBOL	CONDITIONS	ТҮР	MIN/MAX OVER TEMPERATURE					
		CONDITIONS	+25℃	+25℃	-40℃to+85℃	UNITS	MIN/MAX		
INPUT CHARACTERISTIC	S		I						
Input Offset Voltage	Vos	$V_{CM} = VS/2$	0.4	3.5	5.6	mV	MAX		
Input Bias Current	I <sub>B</sub>		1			pА	TYP		
Input Offset Current	los		1			pА	TYP		
Common-Mode	N		-0.1 to			V			
Voltage Range	V <sub>CM</sub>	V <sub>s</sub> = 5.5V	+5.6			V	TYP		
Common-Mode		$V_{\rm S}$ =5.5V, $V_{\rm CM}$ = -0.1V to 4V	70	62	62	dB	N 41 N I		
Rejection Ratio	CMRR	V <sub>S</sub> =5.5V, V <sub>CM</sub> = -0.1V to 5.6V	68	56	55		MIN		
Open-Loop Voltage Gain A <sub>OL</sub>		R∟=5kΩ, V₀= +0.1V to +4.9V	80	70	70	dB			
		$R_L$ =10k $\Omega$ , V <sub>0</sub> =+0.1V to +4.9V	100	90	85		MIN		
Input Offset Voltage Drift	$\Delta V_{OS}/\Delta_T$		2.7			μV/℃	TYP		
OUTPUT CHARACTERIS	rics	I	1	1	L				
	V <sub>он</sub>	R <sub>L</sub> = 100kΩ	4.997	4.990	4.980	V	MIN		
Output Voltage	V <sub>OL</sub>	R <sub>L</sub> = 100kΩ	3	10	20	mV	MAX		
Swing from Rail	Vон	R <sub>L</sub> = 10kΩ	4.992	4.970	4.960	V	MIN		
	V <sub>OL</sub>	R <sub>L</sub> = 10kΩ	8	30	40	mV	MAX		
	I <sub>SOURCE</sub>		84	60	45	mA	MIN		
Output Current	I <sub>SINK</sub>	R∟= 10Ω to VS/2	75	60	45				
POWER SUPPLY	1		1						
				2.1	2.5	V	MIN		
Operating Voltage Range				5.5	5.5	V	MAX		
Power Supply		V <sub>s</sub> = +2.5V to +5.5V,							
Rejection Ratio	PSRR	V <sub>CM</sub> = +0.5V	82	60	58	dB	MIN		
Quiescent Current /									
Amplifier	Ι <sub>Q</sub>		40	60	80	μA	MAX		
DYNAMIC PERFORMANC	E (CL = 10	DpF)	1		1		1		
Gain-Bandwidth Product	GBP		1			MHz	TYP		
Slew Rate	SR	G = +1, 2V Output Step	0.6			V/µs	TYP		
Settling Time to 0.1%	ts	G = +1, 2V Output Step	5			μs	TYP		
Overload Recovery Time		V <sub>IN</sub> ·Gain = VS	2.6			μs	TYP		
NOISE PERFORMANCE	1	1	1	1	1	I	1		
		f = 1kHz	27			nV /√Hz	TYP		
Voltage Noise Density	en	f = 10kHz	20			nV/√Hz	TYP		

(At Vs = +5V, RL = 100k $\Omega$  connected to Vs/2, and Vout = Vs/2, unless otherwise noted.)



## **Typical Performance characteristics**



100 75

60

45

30

15

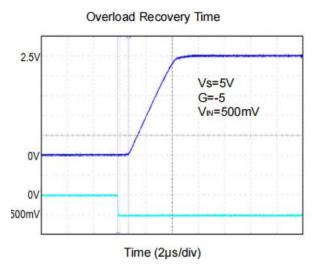
15

10000

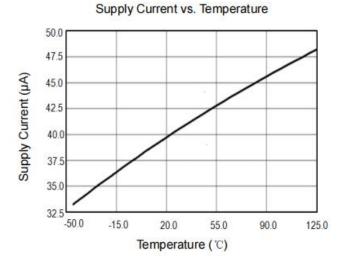
Phase Shift (Degrees)

## **Typical Performance characteristics**

HGC

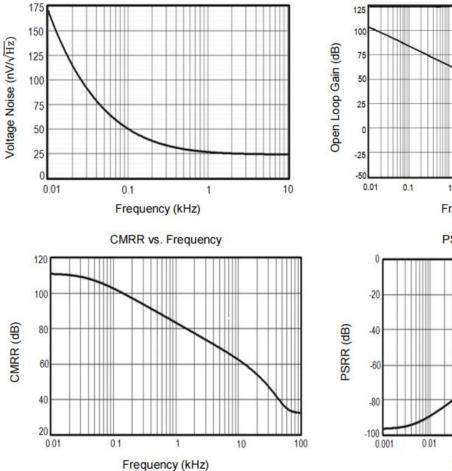


At T<sub>A</sub>=+25°C, V<sub>S</sub>=+5V, and R<sub>L</sub>=100K $\Omega$  connected to V<sub>S</sub>/2, unless otherwise noted.



Open Loop Gain, Phase Shift vs. Frequency at +5V

Input Voltage Noise Spectral Density vs. Frequency

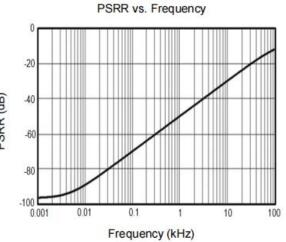


Frequency (kHz)

100

1000

10





## **Application Note**

#### Power Supply Bypassing and Board Layout

LMV602 series operates from a single 2.1V to 5. 5V supply or dual  $\pm 1.05V$  to  $\pm 2.75V$  supplies. For best performance, a 0.1µF ceramic capacitor should be placed close to the VDD pin in single supply operation. For dual supply operation, both V<sub>DD</sub> and VSS supplies should be bypassed to ground with separate 0.1µF ceramic capacitors.

#### Low Supply Current

The low supply current (typical 40uA per channel) of LMV602 will help to maximize battery life. They are ideal for battery powered systems

#### **Operating Voltage**

LMV602 operates under wide input supply voltage (2.1V to 5.5V). In addition, all temperature specifications apply from -40°C to +125°C. Most behavior remains unchanged throughout the full operating voltage range. These guarantees ensure operation throughout the single Li-Ion battery lifetime

#### Rail-to-Rail Input

The input common-mode range of LMV602 extends 100mV beyond the supply rails (VSS-0.1V to VDD+0.1V). This is achieved by using complementary input stage. For normal operation, inputs should be limited to this range.

#### **Rail-to-Rail Output**

Rail-to-Rail output swing provides maximum possible dynamic range at the output. This is particularly important when operating in low supply voltages. The output voltage of LMV602 can typically swing to less than 5 mV from supply rail in light resistive loads (>100k $\Omega$ ), and 30mV of supply rail in moderate resistive loads (10k $\Omega$ ).

#### **Capacitive Load Tolerance**

The LMV602 is optimized for bandwidth and speed, not for driving capacitive loads. Output capacitance will create a pole in the amplifier's feedback path, leading to excessive peaking and potential oscillation. If dealing with load capacitance is a requirement of the application, the two strategies to consider are (1) using a small resistor in series with the amplifier's output and the load capacitance and (2) reducing the bandwidth of the amplifier's feedback loop by increasing the overall noise gain. Figure 2. shows a unity gain follower using the series resistor strategy. The resistor isolates the output from the capacitance and, more importantly, creates a zero in the feedback path that compensates for the pole created by the output capacitance.



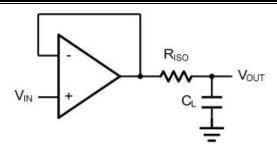


Figure 2. Indirectly Driving a Capacitive Load Using Isolation Resistor

The bigger the RISO resistor value, the more stable VOUT will be. However, if there is a resistive load RL in parallel with the capacitive load, a voltage divider (proportional to RISO/RL) is formed, this will result in a gain error.

The circuit in Figure 3 is an improvement to the one in Figure 2. RF provides the DC accuracy by feed-forward the VIN to RL. CF and RISO serve to counteract the loss of phase margin by feeding the high frequency component of the output signal back to the amplifier's inverting input, thereby preserving the phase margin in the overall feedback loop. Capacitive drive can be increased by increasing the value of CF. This in turn will slow down the pulse response.

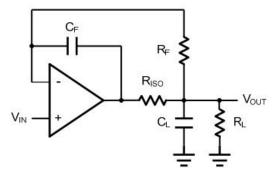
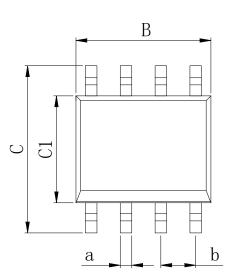


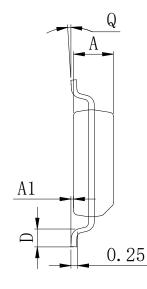
Figure 3. Indirectly Driving a Capacitive Load with DC Accuracy



# **Physical Dimensions**

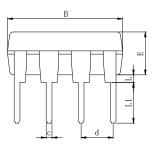
### SOP-8



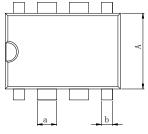


Dimensions In Millimeters(SOP-8)										
Symbol:	А	A1	В	С	C1	D	Q	а	b	
Min:	1.35	0.05	4.90	5.80	3.80	0.40	0°	0.35	1.27 BSC	
Max:	1.55	0.20	5.10	6.20	4.00	0.80	8°	0.45	1.27 850	

#### DIP-8





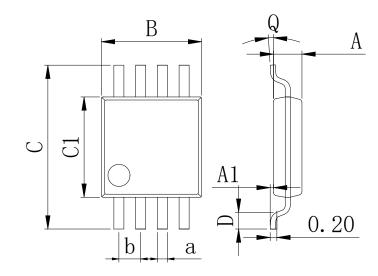


Dimensions In Millimeters(DIP-8)											
Symbol:	A	В	D	D1	E	L	L1	а	b	С	d
Min:	6.10	9.00	8.10	7.42	3.10	0.50	3.00	1.50	0.85	0.40	2 54 800
Max:	6.68	9.50	10.9	7.82	3.55	0.70	3.60	1.55	0.90	0.50	2.54 BSC



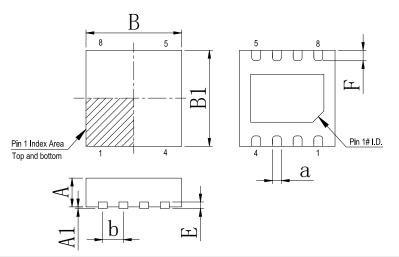
# **Physical Dimensions**

### MSOP-8



Dimensions In Millimeters(MSOP-8)										
Symbol:	А	A1	В	С	C1	D	Q	а	b	
Min:	0.80	0.05	2.90	4.75	2.90	0.35	0°	0.25	0.65 BSC	
Max:	0.90	0.20	3.10	5.05	3.10	0.75	8°	0.35	0.05 650	

#### DFN-8 2\*2



Dimensions In Millimeters(DFN-8 2*2)										
Symbol:	A	A1	В	B1	E	F	а	b		
Min:	0.85	0	1.90	1.90	0.15	0.25	0.18	0.50TYP		
Max:	0.95	0.05	2.10	2.10	0.25	0.45	0.30	0.5011P		



# **Revision History**

DATE	REVISION	PAGE
2014-6-4	New	1-11
2023-8-28	Update encapsulation type、Update Lead Temperature、Updated DIP-8 dimension	1、2、8



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